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# AOTF256L

## 150V N-Channel MOSFET

## **General Description**

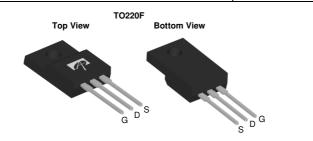
The AOTF256L uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of  $R_{\rm DS(ON)},$  Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

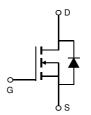
## **Product Summary**

 $\begin{array}{lll} V_{DS} & 150V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 12A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 85 m \Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 100 m \Omega \end{array}$ 

100% UIS Tested 100%  $R_g$  Tested







Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V <sub>DS</sub>	150	V				
Gate-Source Voltage		V <sub>GS</sub>	±20	V				
Continuous Drain	T <sub>C</sub> =25℃		12					
Current	T <sub>C</sub> =100℃	I <sub>D</sub>	8.5	A				
Pulsed Drain Current C		I <sub>DM</sub>	35					
Continuous Drain	T <sub>A</sub> =25℃		3	A				
Current	T <sub>A</sub> =70℃	IDSM	2.5	^				
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	9	A				
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub>	4	mJ				
	T <sub>C</sub> =25℃	В	33	W				
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100℃	P <sub>D</sub>	16	VV				
	T <sub>A</sub> =25℃	В	2.1	14/				
Power Dissipation A	T <sub>A</sub> =70℃	P <sub>DSM</sub>	1.3	W				
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	.c				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	12	15	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	50	60	℃/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3.8	4.6	℃/W			



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter Conditions		Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V$	150			V				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =150V, V <sub>GS</sub> =0V			1	μA				
D00	come i comego - com com com	T <sub>J</sub> =55℃			5					
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V			±100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1.8	2.25	2.8	V				
$I_{D(ON)}$	On state drain current	$V_{GS}=10V, V_{DS}=5V$	35			Α				
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =10A		70	85	mΩ				
		T <sub>J</sub> =125℃		139	170	11132				
		$V_{GS}$ =4.5V, $I_D$ =8A		78	100	$m\Omega$				
g <sub>FS</sub>	Forward Transconductance	$V_{DS}=5V$ , $I_{D}=10A$		35		S				
$V_{SD}$	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.72	1	V				
$I_S$	Maximum Body-Diode Continuous Curr			12	Α					
DYNAMIC	PARAMETERS									
C <sub>iss</sub>	Input Capacitance			1165		pF				
C <sub>oss</sub>	Output Capacitance	$V_{GS}=0V$ , $V_{DS}=75V$ , $f=1MHz$		61.5		рF				
C <sub>rss</sub>	Reverse Transfer Capacitance	]		2.5		рF				
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	1.1	2.2	3.3	Ω				
SWITCHI	NG PARAMETERS									
Q <sub>g</sub> (10V)	Total Gate Charge			15.5	22	nC				
Q <sub>g</sub> (4.5V)	Total Gate Charge	V 10V V 75V L 10A		7	10	nC				
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =10V, $V_{DS}$ =75V, $I_{D}$ =10A		4		nC				
$Q_{gd}$	Gate Drain Charge	1		1.2		nC				
$t_{D(on)}$	Turn-On DelayTime			6.5		ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =75V, $R_L$ =7.5 $\Omega$ ,		5		ns				
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		23		ns				
t <sub>f</sub>	Turn-Off Fall Time	]		2.5		ns				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =10A, dI/dt=500A/μs		37		ns				
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =10A, dI/dt=500A/μs		265		nC				

A. The value of  $R_{0JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^{\circ}$  C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

  F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

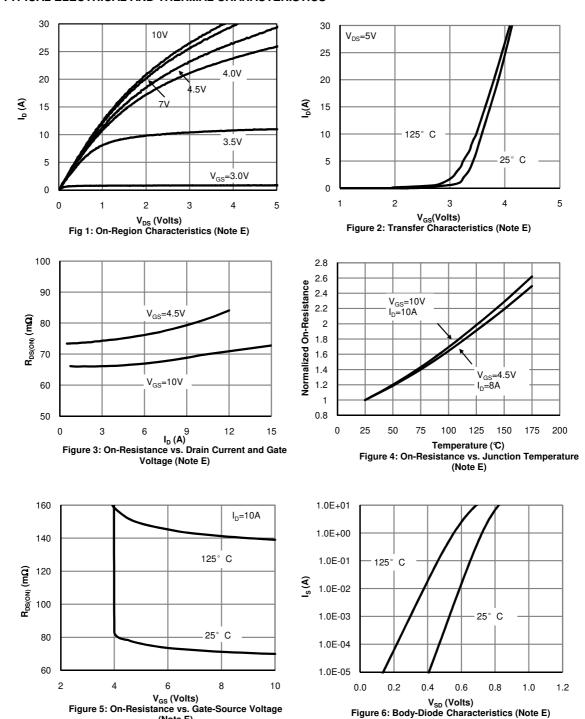
C. Repetitive rating, pulse width limited by junction temperature T<sub>J/(MAX)</sub>=175° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub> =25° C.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



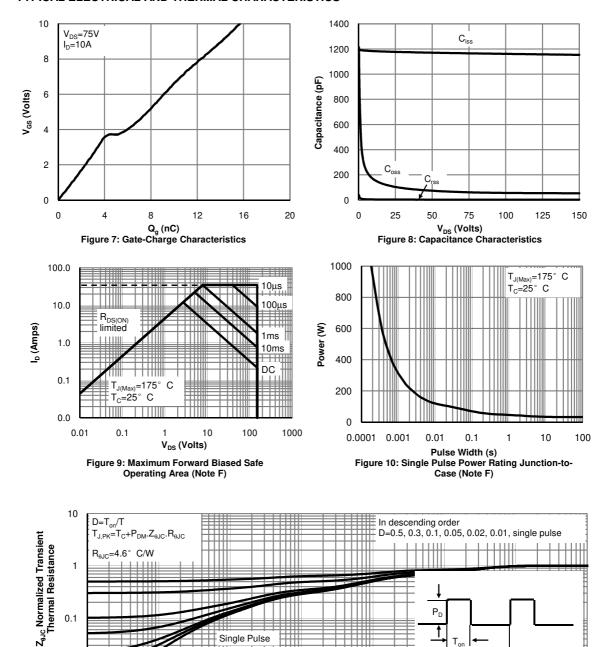
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)





#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

10

100

0.01

Single Pulse

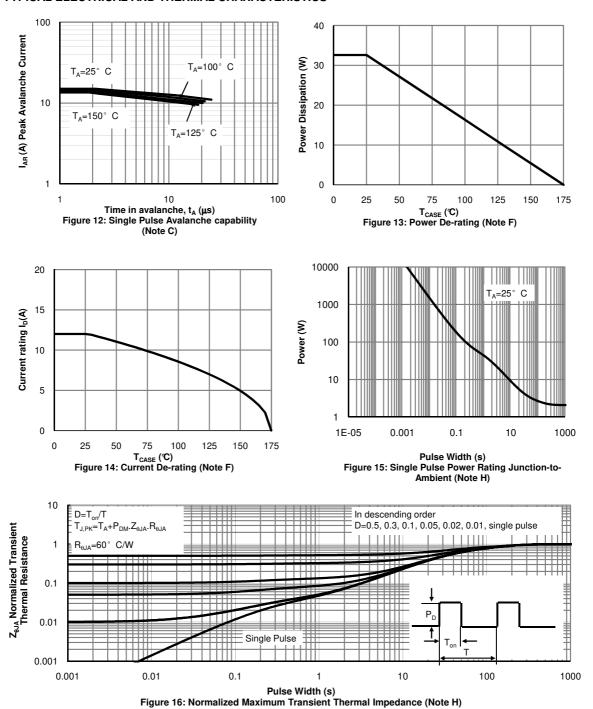
0.001

0.01 1E-05

0.0001

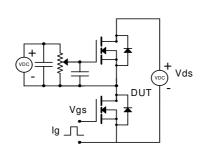


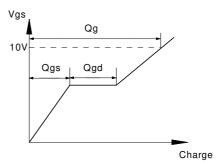
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



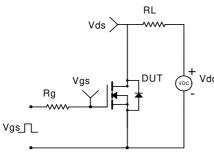


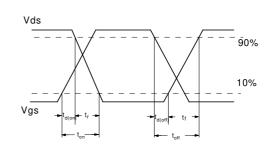
## Gate Charge Test Circuit & Waveform



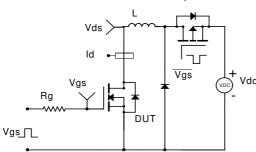


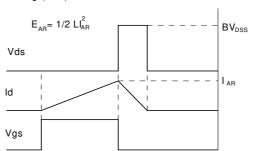
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

